

**Notice of References Cited**

Application/Control No.

09/974,641

Applicant(s)/Patent Under  
Reexamination  
BOUDREAU ET AL.

Examiner

Kin-Chan Chen

Art Unit

1765

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,483,969	11-2002	Yap et al.	385/52
	B	US-6,344,148	02-2002	Park et al.	216/2
	C	US-5,550,088	08-1996	Dautartas et al.	216/2
	D	US-5,981,975	11-1999	Imhoff, Eugene A.	257/81
	E	US-6,516,448	02-2003	Vieider et al.	716/2
	F	US-6,163,639	12-2000	Ollier et al.	385/52
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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